



INSULATED GATE BIPOLAR TRANSISTOR

$$V_{CES} = 1200V$$

$$I_{C(Nominal)} = 30A$$

$$T_{J(max)} = 175^{\circ}C$$

$$V_{CE(on)} typ = 1.69V @ I_C = 30A$$

G C E Gate Collector Emitter

Applications

- Medium Power Drives
- UPS
- HEV Inverter
- Welding
- Induction Heating

Features —	→ Benefits
Low V _{CE(ON)} and switching Losses	High efficiency in a wide range of applications and switching frequencies
Square RBSOA and Maximum Junction Temperature 175°C	Improved Reliability due to rugged hard switching performance and higher power capability
Positive V _{CE (ON)} Temperature Coefficient	Excellent current sharing in parallel operation

Page part number		Dookogo Typo	Standa	rd Pack	Ordereble next number	
	Base part number	Package Type	Form	Quantity	Orderable part number	
	IRG7CH42UEF	Die on film	Wafer	1	IRG7CH42UEF	

Mechanical Parameter

Die Size	4.699 x 6.35 mm ²			
Minimum Street Width	75	μm		
Emiter Pad Size (Included Gate Pad)	See Die Drawing			
Gate Pad Size	0.503 x 0.501	mm ²		
Area Total / Active	29.84/17.74			
Thickness	120	μm		
Wafer Size	200	mm		
Flat Position	0	Degrees		
Maximum-Possible Chips per Wafer	914 pcs			
Passivation Front side	Silicon Nitride			
Front Metal	Al, Si (4μm)			
Backside Metal	Al- Ti - Ni- Ag (1kA°-1kA°-4kA°-6kA°)			
Die Bond	Electrically conductive epoxy or solder			
Reject Ink Dot Size	0.25 mm diameter minimum			

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Maximum Ratings

	Parameter	Max.	Units
V_{CE}	Collector-Emitter Voltage, T _J =25°C	1200	V
I_{C}	DC Collector Current	①	Α
I _{LM}	Clamped Inductive Load Current ②	120	Α
$V_{\sf GE}$	Gate Emitter Voltage	± 30	V
T_{J}, T_{STG}	Operating Junction and Storage Temperature	-40 to +175	°C

Static Characteristics (Tested on wafers) . T_J=25°C

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	1200				$V_{GE} = 0V, I_{C} = 100\mu A$ ③
$V_{CE(sat)}$	Collector-to-Emitter Saturated Voltage		1.17	1.40	V	$V_{GE} = 15V, I_{C} = 5A, T_{J} = 25^{\circ}C$
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	3.0		6.0		$I_C = 1 \text{mA}$, $V_{GE} = V_{CE}$
I _{CES}	Zero Gate Voltage Collector Current		1.0	150	μΑ	$V_{CE} = 1200V, V_{GE} = 0V$
I_{GES}	Gate Emitter Leakage Current			± 100	nA	$V_{CE} = 0V, V_{GE} = \pm 30V$

Electrical Characteristics (Not subject to production test- Verified by design/characterization)

Electrical Characteristics (Not subject to production test- verified by design/characterization)						
	Parameter	Min.	Тур.	Max.	Units	Conditions
			1.69	2.02	.,	V _{GE} = 15V, I _C = 30A , T _J = 25°C ④
$V_{CE(sat)}$	Collector-to-Emitter Saturated Voltage		2.07		V	V _{GE} = 15V, I _C = 30A , T _J = 150°C4
						$T_J = 150^{\circ}\text{C}, I_C = 120\text{A}$
RBSOA	Reverse Bias Safe Operating Area	FULL SQUARE				V _{CC} = 960V, Vp ≤1200V
						Rg = 10Ω , V_{GE} = +20V to 0V
C _{iss}	Input Capacitance		3338			$V_{GE} = 0V$
C_{oss}	Output Capacitance		124		рF	V _{CE} = 30V
C _{rss}	Reverse Transfer Capacitance		75			f = 1.0MHz,
Q_g	Total Gate Charge (turn-on)		157			I _C = 30A
Q_{ge}	Gate-to-Emitter Charge (turn-on)		21		nC	V _{GE} = 15V
Q_{gc}	Gate-to-Collector Charge (turn-on)	_	69			V _{CC} = 600V

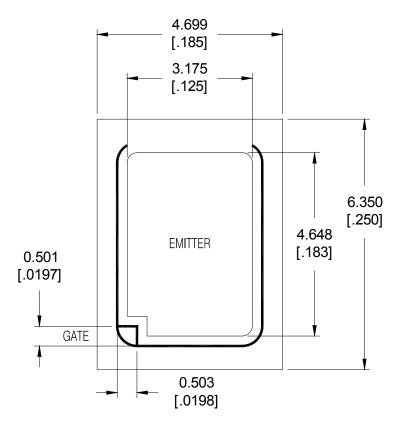
Switching Characteristics (Inductive Load-Not subject to production test-Verified by design/characterization)

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	Parameter	Min.	Тур.	Max.	Units	Conditions ©
$t_{d(on)}$	Turn-On delay time	_	25	_		I _C = 30A, V _{CC} = 600V
t _r	Rise time	_	32	_		$R_G = 10\Omega$, $V_{GE} = 15V$, $L = 200\mu H$
$t_{d(off)}$	Turn-Off delay time	_	229	_		$T_J = 25^{\circ}C$
t _f	Fall time	_	63	_]	
$t_{d(on)}$	Turn-On delay time	_	20	_	ns	$I_{\rm C}$ = 30A, $V_{\rm CC}$ = 600V
t _r	Rise time	_	31	_		$R_G = 10\Omega$, $V_{GE} = 15V$, $L = 200\mu H$
$t_{d(off)}$	Turn-Off delay time	_	310	_		T _J = 175°C
t _f	Fall time		162	_		

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Die Drawing



NOTES:

- 1. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 2. CONTROLLING DIMENSION: [INCH].
- 3. LETTER DESIGNATION:
 - S = SOURCE SK = SOURCE KELVIN E = EMITTER
 - G = GATE IS = CURRENTSENSE
- 4. DIMENSIONAL TOLERANCES:

BONDING PADS: < 0.635 TOLERANCE = +/- 0.013

WIDTH < [.0250] TOLERANCE = +/- [.0005]
& > 0.635 TOLERANCE = +/- 0.025

LENGTH > [.0250] TOLERANCE = +/- [.0010]

OVERALL DIE: < 1.270 TOLERANCE = +/- 0.102

WIDTH < [.050] TOLERANCE = +/- [.004]

& > 1.270 TOLERANCE = +/- 0.203 LENGTH > [.050] TOLERANCE = +/- [.008]

5. DIE THICKNESS = 0.120 [.0047]

REFERENCE: IRG7PH42UD-EPBF IRG7PH42UDPBF

Notes:

 \odot The current in the application is limited by T_{JMax} and the thermal properties of the assembly.

- $@V_{CC} = 80\%$ (V_{CES}), V_{GE} = 20V, L = 200μH, R_G = 10Ω.
- ③Refer to AN-1086 for guidelines for measuring V_{(BR)CES} safely
- ©Values influenced by parasitic L and C in measurement

3



Additional Testing and Screening

For Customers requiring product supplied as Known Good Die (KGD) or requiring specific die level testing, please contact your local IR Sales.

Shipping

Sawn Wafer on Film. Please contact your local IR sales office for non-standard shipping options

Handling

- Product must be handled only at ESD safe workstations. Standard ESD precautions and safe work environments are as defined in MIL-HDBK-263.
- Product must be handled only in a class 10,000 or better-designated clean room environment.
- Singulated die are not to be handled with tweezers. A vacuum wand with a non-metallic ESD protected tip should be used.

Wafer/Die Storage

- Proper storage conditions are necessary to prevent product contamination and/or degradation after shipment.
- Note: To reduce the risk of contamination or degradation, it is recommended that product not being used in the
 assembly process be returned to their original containers and resealed with a vacuum seal process.
- Sawn wafers on a film frame are intended for immediate use and have a limited shelf life.

Further Information

For further information please contact your local IR Sales office or email your enquiry to http://die.irf.com

Data and specifications subject to change without notice. This product has been designed and qualified for Industrial market.

Qualification Standards can be found on IR's Web site.



IR WORLD HEADQUARTERS: 101N. Sepulveda Blvd, El Segundo, California 90245, USA Tel: (310) 252-7105
TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.